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(54) FRONT PANEL FOR MEASUREMENT INSTRUMENTS

(75) Inventors: **Michael D. Nelson**, Seattle, WA (US); **David K. Orr**, Seattle, WA (US)

(73) Assignee: Tektronix, Inc., Beaverton, OR (US)

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	329/155, 156; 337/112, 327, 360; 340/653,
	340/660; 379/21; 439/482; D24/185-186,
	D24/232-234; D10/80, 102-103; D14/432,
	D14/440, 441; 24/280; 73/431; 116/334,
	116/DIG. 47; 220/214; 236/46 R, 47, 94;
	292/37 R, 256.67; 301/666, 669

See application file for complete search history.

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Primary Examiner—Antoine D. Davis (74) Attorney, Agent, or Firm—William K. Bucher

(57) CLAIM

The ornamental design of a front panel for measurement instruments, as shown and described.

DESCRIPTION

The ornamental design disclosed in this application is for various embodiments of a front panel for measurement instruments, such as oscilloscopes, logic analyzers, waveform generators, and the like.

FIG. 1 is a perspective view of a first embodiment of front panel for measurement instruments;

FIG. 2 is a front elevation view of the first embodiment of front panel for measurement instruments;

FIG. 3 is a left side elevation view of the first embodiment of front panel for measurement instruments;

FIG. 4 is a right side elevation view of the first embodiment of front panel for measurement instruments;

FIG. 5 is a top plan view of the first embodiment of front panel for measurement instruments;

FIG. 6 is a bottom plan view of the first embodiment of front panel for measurement instruments;

FIG. 7 is a perspective view of a second embodiment of front panel for measurement instruments;

FIG. 8 is a front elevation view of the second embodiment of front panel for measurement instruments;

FIG. 9 is a left side elevation view of the second embodiment of front panel for measurement instruments;

FIG. 10 is a right side elevation view of the second embodiment of front panel for measurement instruments;

FIG. 11 is a top plan view of the second embodiment of front panel for measurement instruments;

FIG. 12 is a bottom plan view of the second embodiment of front panel for measurement instruments;

FIG. 13 is a perspective view of a third embodiment of front panel for measurement instruments;

FIG. 14 is a front elevation view of the third embodiment of front panel for measurement instruments;

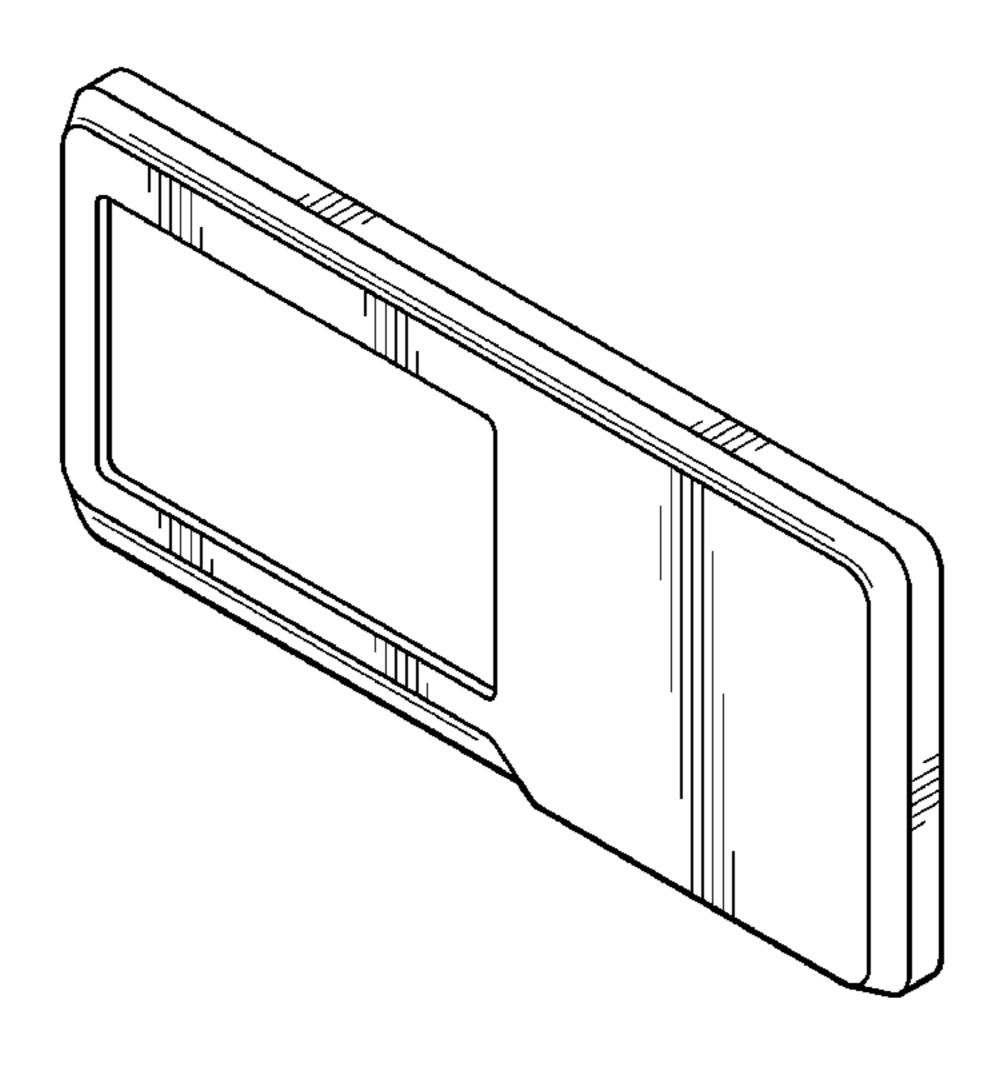


FIG. 15 is a left side elevation view of the third embodiment of front panel for measurement instruments;

FIG. 16 is a right side elevation view of the third embodiment of front panel for measurement instruments;

FIG. 17 is a top plan view of the third embodiment of front panel for measurement instruments; and,

FIG. 18 is a bottom plan view of third embodiment of front panel for measurement instruments.

The front panel has a substantially rectangular front face with a substantially rectangular opening disposed in a por-

tion thereof, first beveled surfaces extending from side and top surfaces and from a first portion of a bottom surface to the rectangular front face, and a second beveled surface extending from a second portion of the bottom surface to the rectangular front face with the second beveled surface laterally transitioning from the first beveled surface.

1 Claim, 6 Drawing Sheets

